10585733 - GAU: 2826 **10/585733**

JAP20 Rec'd PCT/PTO 12 JUL 2006

03500.109228.

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

| In re Application of: |) | Evaminary Not Vot Assigned |
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| TAKESHI ICHIKAWA | j | Examiner: Not Yet Assigned Art Unit: Not Yet Assigned |
| Application No.: Not Yet Assig (National Phase of Int'l Appl PCT/JP2005/006226, filed M | ication No. : | Art Ollit. Not Tet Assigned |
| Filed: Concurrently Herewith | ; | |
| For: SEMICONDUCTOR AP SOLID STATE IMAGE I DEVICE USING THE SA METHOD OF MANUFA THEM | PICKUP : AME, AND) | July 11, 2006 |

Mail Stop: PCT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents identified on the enclosed Form PTO-1449. Copies of those documents are also enclosed, except for the U.S. patents..

For the concise explanation of relevance for the non-English document, Japanese Patent Application Laid-Open No. H07-297295, the Examiner is referred to the accompanying English abstract.

For the concise explanation of relevance for the non-English documents, Japanese Patent Application Laid-Open No. 7-321220 and Japanese Patent Application

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IP208cc'dPGT/710 12 JUL 2006

Nos. 2000-353756, 2002-329793, 2000-077613, 2004-158508 and 2003-333431, the Examiner is referred to accompanying English abstracts, and to the PCT International Search Report mailed July 12, 2005, for International Application No.

PCT/JP2005/006226, of which this application is the U.S. national phase. A copy of that Search Report is also enclosed.

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Applicant's undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address given below.

Respectfully submitted,

Jennifer A. Reda

Attorney for Applicant Registration No. 57,840

FITZPATRICK, CELLA, HARPER & SCINTO 30 Rockefeller Plaza New York, New York 10112-3800 Facsimile: (212) 218-2200

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FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)

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National Phase Of JP/2005/006226

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FILING DATE

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| | | | U.S. PA | ATENT DOCUMENTS | 1 | | |
| *EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE |
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| /S.A./ | | 5,438,211 | 08/01/95 | Nakamura et al. | 257 | 239 | |
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| /S.A./ | JP | H07-297295 | 11/10/95 | Japan | | | Abstrac |
| /S.A./ | JP | 2004-158508 A | 06/03/04 | Japan | | | Abstract |
| /S.A./ | JP | 2003-333431 A | 11/21/03 | Japan | | | Abstrac |
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| /S.A./ | JP | 07-321220 A | 12/08/95 | Japan | | | Abstrac |
| | | | | | | | |
| • | | OTHER | DOCUMENT(S) (Included) | ding Author, Title, Date, Pertinent Pages, Etc.) | | <u> </u> | |
| | | | | | | | |
| EXAMINER | | /Selim Ahmed/ | | DATE CONSIDERED 11/09/2 | 2008 | | |

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet _ 1 _ of _ 1 _